

# TOSHIBA MOS MEMORY PRODUCTS

TC521000P/J

1Mbit (256K x 4) Field Memory

PRELIMINARY

## DESCRIPTION

The TC521000P/J is a CMOS 1Mbit Field Memory organized as 256K words by 4 bits, and features separate inputs/outputs, each equipped with an 8 bit serial shift register (32K words x 8 bit shift register x 4 bits), and also features high speed operation with a clock rate of 33MHz (serial cycle time: 30ns). The TC521000P/J is a high speed serial read/write memory with a random access capability per 8 words, and is suitable for use in field/frame memory in digital TV, VCR and other video applications which require improvements in picture quality and enhancements in performance. The TC521000P/J is fabricated using TOSHIBA's CMOS silicon gate process technology as well as advanced circuitry to provide low power dissipation and wide operating margins.

## FEATURES

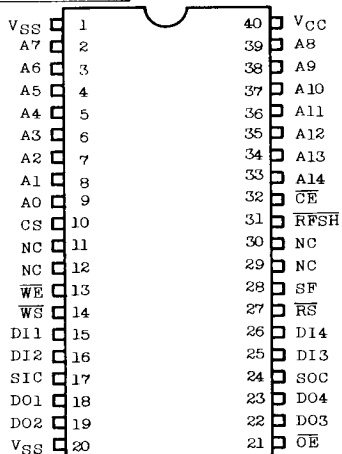
- High speed and low power

Serial Access Time	20ns	
Serial Read Cycle Time	30ns	
Serial Write Cycle Time	30ns	
Read, Write Cycle Time	190ns	
Read-Modify-Write Cycle Time	240ns	
Read-Read-Write Cycle Time	480ns	
Power Dissipation	Operating Power	550mW
	Standby Power	110mW

- Organization: 32K word x 8bit shift register x 4bit

- Single 5V power supply: 5V±10%
- On-chip 8bit shift registers
- Separate inputs and outputs
- Serial read/write, Read/Write, Read-Modify-Write, High Speed Read-Read-Write capability
- Random Access Capability per 8 word
- 8ms/512 refresh cycles
- On-chip refresh counter
- All inputs and outputs: TTL compatible
- Package: 40 pin 600mils wide standard plastic DIP

## PIN CONNECTION



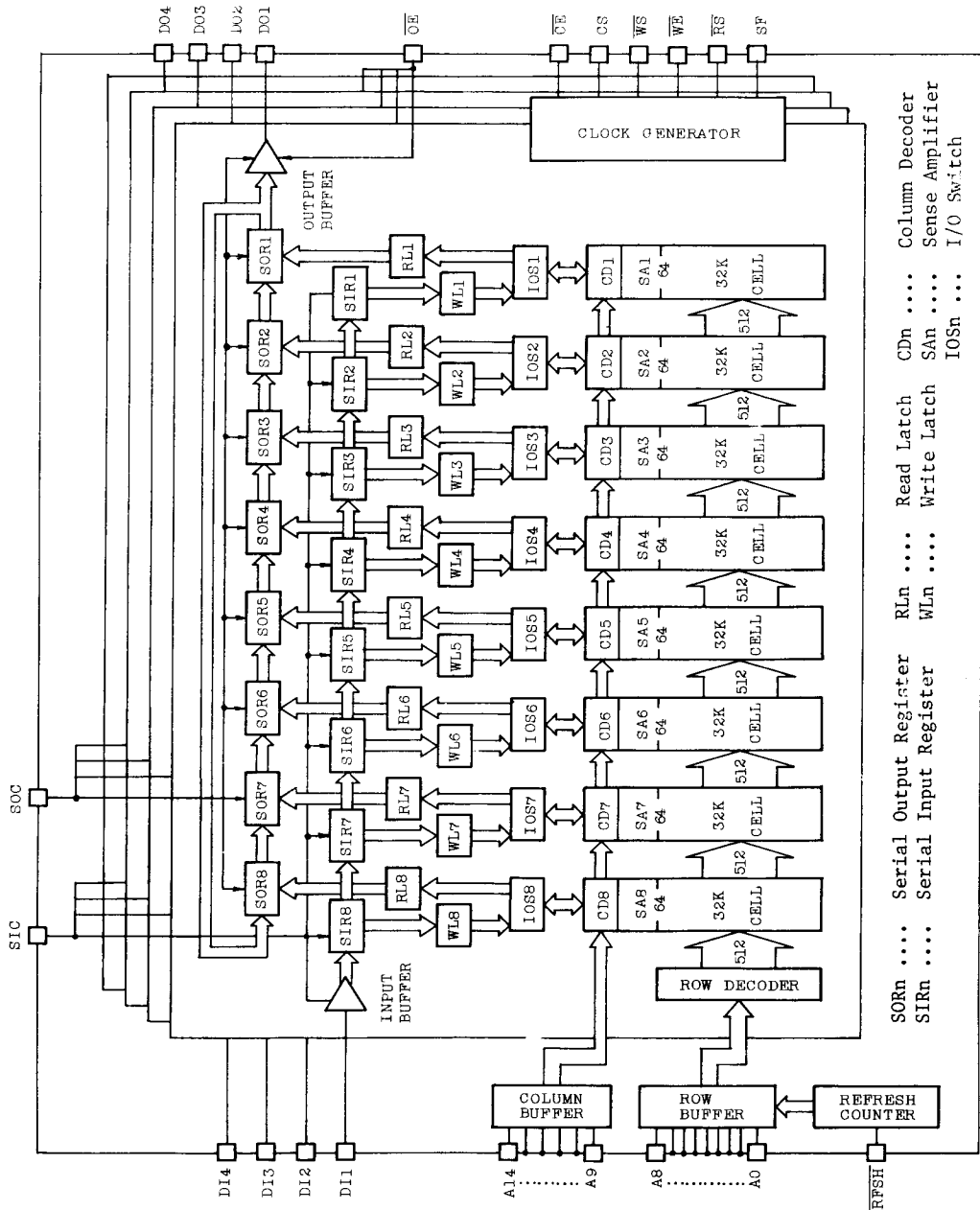
40-pin 600 mil DIP, 400 mil SOJ

## PIN NAMES

SYMBOL	NAME
AO ~ A14	Address Input
CE	Chip Enable Input
OE	Output Enable Input
WE	Write Enable Input
WS	Write Strobe Input
RS	Read Strobe Input
CS	Chip Select Input
SIC	Serial Input Clock Input
SOC	Serial Output Clock Input
DI1 ~ DI4	Data Input
DO1 ~ DO4	Data Output
RFSH	Refresh Control Input
SF	Special Function Input
VCC	Ground (5V)
VSS	Ground (0V)
NC	Non Connection

# TC521000P/J

**BLOCK DIAGRAM**



PIN NAMES AND FUNCTIONS

SYMBOL	NAME	FUNCTION
A0 ~ A8	Row Address Inputs	Row Addresses
A9 ~ A14	Column Address Inputs	Column Addresses The A14 is a column LSB address and is controlled internally by SF signal.
$\overline{CE}$	Chip Enable Input	The falling edge of $\overline{CE}$ latches the A0 ~ A14 and CS. The read data is retained in Read Latch (RL), even if the $\overline{CE}$ goes high.
CS	Chip Select Input	The low CS forbid the memory cell access operation, but allows the refresh operation. ( $\overline{CE}$ ONLY REFRESH)
$\overline{RS}$	Read Strobe Input	The $\overline{RS}$ controls the transfer operation to Output Shift Register from Read Latch (RL).
SF	Special Function	The SF controls the column LSB A14 internally.
$\overline{WS}$	Write Strobe Input	The $\overline{WS}$ controls the transfer operation to Write Latch (WL) from Input Shift Register.
$\overline{WE}$	Write Enable Input	The $\overline{WE}$ controls the write operation into the memory cell.
$\overline{OE}$	Output Enable Input	The $\overline{OE}$ enables the D01 ~ D04 output buffers.
$\overline{RFSH}$	Refresh Control Input	The $\overline{RFSH}$ controls the auto refresh operation.
SOC	Serial Output Clock Input	The SOC is a shift clock input to Output Shift Register.
SIC	Serial Input Clock Input	The SIC is a shift clock input to Input Shift Register.
D01 ~ D04	Data Outputs	Serial Output Terminals.
DI1 ~ DI4	Data Inputs	Serial Input Terminals.

# TC52100P/J

## ABSOLUTE MAXIMUM RATINGS (Note: 1)

SYMBOL	ITEM	RATING	UNITS	NOTES
V <sub>IN</sub> ·V <sub>OUT</sub>	Input · Output Voltage	-1 ~ 7	V	2
V <sub>CC</sub>	Power Supply Voltage	-1 ~ 7	V	2
T <sub>opr</sub>	Operating Temperature	0 ~ 70	°C	
T <sub>stg</sub>	Storage Temperature	-55 ~ 150	°C	
T <sub>solder</sub>	Soldering Temperature · Time	260 · 10	°C · sec	
P <sub>D</sub>	Power Dissipation	1	W	
I <sub>OUT</sub>	Short Circuit Output Current	50	mA	

## RECOMMENDED DC OPERATING CONDITIONS (Ta=0 ~ 70°C)

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNITS	NOTES
V <sub>CC</sub>	Power Supply Voltage	4.5	5.0	5.5	V	2
V <sub>IH</sub>	Input High Voltage	2.4	-	6.5	V	2
V <sub>IL</sub>	Input Low Voltage	-1.0	-	0.8	V	2

## DC ELECTRICAL CHARACTERISTICS (V<sub>CC</sub>=5V±10%, Ta=0 ~ 70°C)

SYMBOL	PARAMETER	MIN.	(10) TYP.	MAX.	UNITS	NOTES
I <sub>CC1</sub>	OPERATING CURRENT (CE, SIC, SOC Cycling: t <sub>C</sub> , t <sub>SIC</sub> , t <sub>SOC</sub> =min.)	-	65	100	mA	3, 4
I <sub>CC2</sub>	STANDBY CURRENT (CE=OE=V <sub>IH</sub> , SIC=SOC=V <sub>IL</sub> )	-	3	20	mA	
I <sub>CC3</sub>	REFRESH CURRENT (RFSH Cycling: t <sub>FC</sub> =t <sub>FC</sub> min.)	-	50	100	mA	3
I <sub>I1(L)</sub>	INPUT LEAKAGE CURRENT (Except for SF Pin) (0V ≤ V <sub>IN</sub> ≤ 6.5V, All other pins not under test=0V)	-10	-	10	μA	
I <sub>I2(L)</sub>	INPUT LEAKAGE CURRENT (SF Pin ONLY) (0V ≤ V <sub>IN</sub> ≤ 6.5V, All other pins not under test=0V)	-50	-	50	μA	
I <sub>O(L)</sub>	OUTPUT LEAKAGE CURRENT (0V ≤ V <sub>OUT</sub> ≤ V <sub>CC</sub> , Output is disabled)	-10	-	10	μA	
V <sub>OH</sub>	OUTPUT HIGH LEVEL VOLTAGE (I <sub>OUT</sub> =-2mA)	2.4	-	-	V	
V <sub>OL</sub>	OUTPUT LOW LEVEL VOLTAGE (I <sub>OUT</sub> =2mA)	-	-	0.4	V	

## CAPACITANCE (V<sub>CC</sub>=5V±10%, f=1MHz, Ta=0 ~ 70°C)

SYMBOL	PARAMETER	MIN.	MAX.	UNITS	NOTES
C <sub>I1</sub>	Input Capacitance (A0 ~ A14)	-	7	pF	
C <sub>I2</sub>	Input Capacitance (CE, CS, RS, WS, WE, OE, SF, RFSH, SIC, SOC)	-	7	pF	
C <sub>I3</sub>	Input Capacitance (DI1 ~ DI4)	-	7	pF	
C <sub>O</sub>	Output Capacitance (DO1 ~ DO4)	-	9	pF	

AC ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS  
 (V<sub>CC</sub>=5V±10%, T<sub>a</sub>=0 ~ 70°C) (Note: 5, 6, 7)

SYMBOL	PARAMETER	MIN.	MAX.	UNITS	NOTES
t <sub>C</sub>	Read, Write Cycle Time	190		ns	
t <sub>RMW</sub>	Read-Modify-Write Cycle Time (=8x t <sub>SOC</sub> , t <sub>SIC</sub> )	240		ns	
t <sub>RRW</sub>	Read-Read-Write Cycle Time (=16x t <sub>SOC</sub> )	480		ns	
t <sub>CE</sub>	$\overline{CE}$ Pulse Width	100	2,000	ns	
t <sub>P</sub>	$\overline{CE}$ Precharge Time	80		ns	
t <sub>ASC</sub>	Address, CS Set-up Time	0		ns	
t <sub>AHC</sub>	Address, CS Hold Time	50		ns	
t <sub>SOC</sub>	Serial Output Cycle Time	30		ns	
t <sub>SO</sub>	SOC Low Pulse Width	10		ns	
t <sub>SOP</sub>	SOC High Pulse Width	10		ns	
t <sub>SOA</sub>	SOC Access Time		20	ns	8
t <sub>SOH</sub>	SOC Output Data Hold Time	5		ns	
t <sub>SIC</sub>	Serial Input Cycle Time	30		ns	
t <sub>SI</sub>	SIC Low Pulse Width	10		ns	
t <sub>SIP</sub>	SIC High Pulse Width	10		ns	
t <sub>RCS</sub>	Read Command Set-up Time	0		ns	
t <sub>RCH</sub>	Read Command Hold Time	0		ns	
t <sub>CRD</sub>	$\overline{CE}$ - $\overline{RS}$ Delay Time	85		ns	
t <sub>RS</sub>	$\overline{RS}$ Pulse Width	20		ns	
t <sub>RCP</sub>	$\overline{RS}$ - $\overline{CE}$ Precharge Time	0		ns	
t <sub>RSP</sub>	$\overline{RS}$ Precharge Time	30		ns	
t <sub>SOS</sub>	SOC- $\overline{RS}$ Set-up Time	0		ns	
t <sub>SOV</sub>	SOC- $\overline{RS}$ Hold Time	15		ns	
t <sub>RSL</sub>	SIC- $\overline{RS}$ Lead Time	0		ns	
t <sub>OE</sub>	$\overline{OE}$ Pulse Width	30		ns	
t <sub>OEP</sub>	$\overline{OE}$ Precharge Time	30		ns	
t <sub>OEA</sub>	$\overline{OE}$ Access Time		25	ns	8
t <sub>OEZ</sub>	$\overline{OE}$ Output Buffer Turn-off Delay Time	0	30	ns	9
t <sub>RWD</sub>	$\overline{RS}$ - $\overline{WE}$ Delay Time	0		ns	
t <sub>CWD</sub>	$\overline{CE}$ - $\overline{WE}$ Delay Time (Read-Modify-Write Cycle)	90		ns	
t <sub>WHC</sub>	$\overline{WE}$ Hold Time	70		ns	
t <sub>WP</sub>	$\overline{WE}$ Pulse Width	30		ns	
t <sub>CWL</sub>	$\overline{WE}$ - $\overline{CE}$ Lead Time	40		ns	

# TC521000P/J

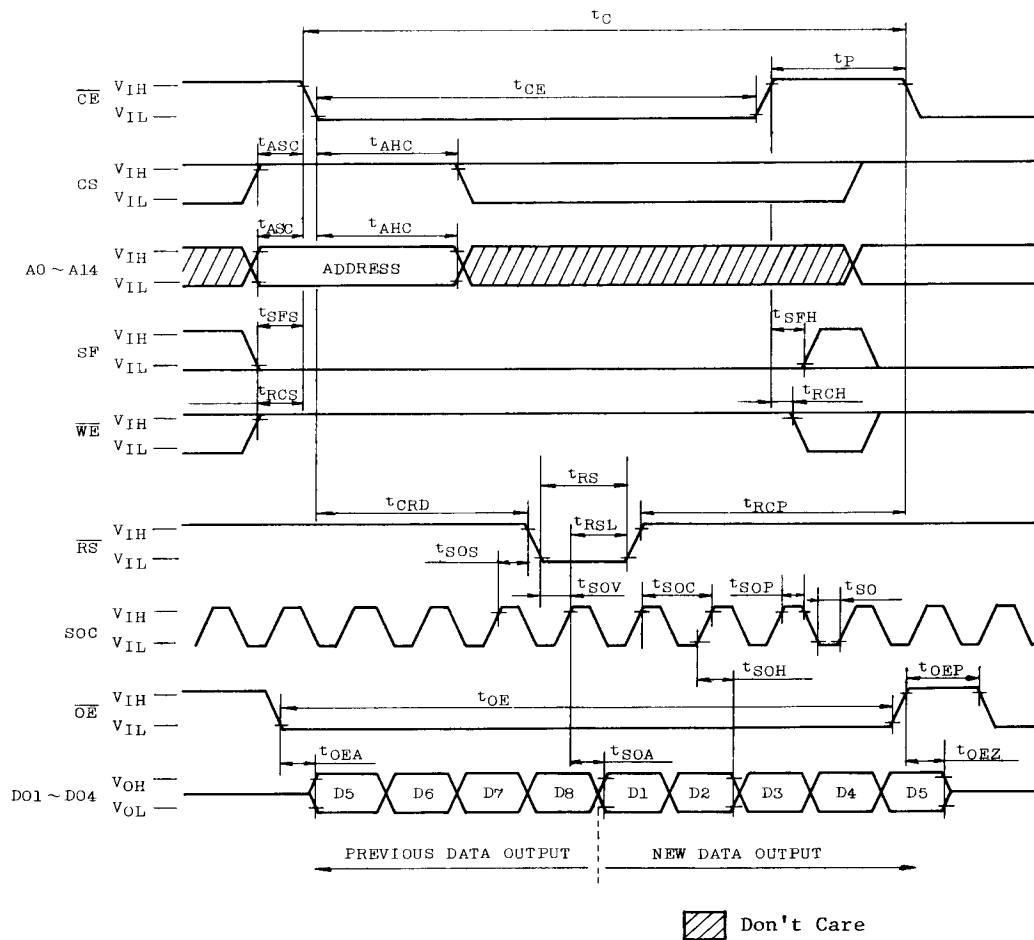
(Continued)

SYMBOL	PARAMETER	MIN.	MAX.	UNITS	NOTES
$t_{SWE}$	$\overline{WS}$ - $\overline{WE}$ Set-up Time	20		ns	
$t_{WS}$	$\overline{WS}$ Pulse Width	20		ns	
$t_{WSP}$	$\overline{WS}$ Precharge Time	30		ns	
$t_{WIH}$	$\overline{WS}$ Inhibit Time referenced to $\overline{WE}$	50		ns	
$t_{WIHC}$	$\overline{WS}$ Inhibit Time referenced to $\overline{CE}$	100		ns	
$t_{SIV}$	SIC- $\overline{WS}$ Set-up Time	5		ns	
$t_{SIH}$	SIC- $\overline{WS}$ Hold Time	10		ns	
$t_{DS}$	Data Input Set-up Time	5		ns	
$t_{DH}$	Data Input Hold Time	5		ns	
$t_{SFS}$	SF- $\overline{CE}$ Set-up Time	0		ns	
$t_{SFH}$	SF- $\overline{CE}$ Hold Time	0		ns	
$t_{CSL}$	SF- $\overline{CE}$ Lead Time (Read-Read-Write Cycle)	50		ns	
$t_{SSH}$	SOC-SF Hold Time (Read-Read-Write Cycle)	20		ns	
$t_T$	Transition Time (Rise and Fall)	3	50	ns	7
$t_{REF}$	Refresh Period		8	ms	
$t_{FC}$	Refresh Cycle Time	190		ns	
$t_{CFD}$	$\overline{CE}$ Precharge- $\overline{RFSH}$ Delay Time	80		ns	
$t_{FAP}$	$\overline{RFSH}$ Pulse Width	100	2,000	ns	
$t_{FP}$	$\overline{RFSH}$ Precharge Time	80		ns	
$t_{FSC}$	$\overline{RFSH}$ Precharge- $\overline{CE}$ Delay Time	80		ns	

## Note

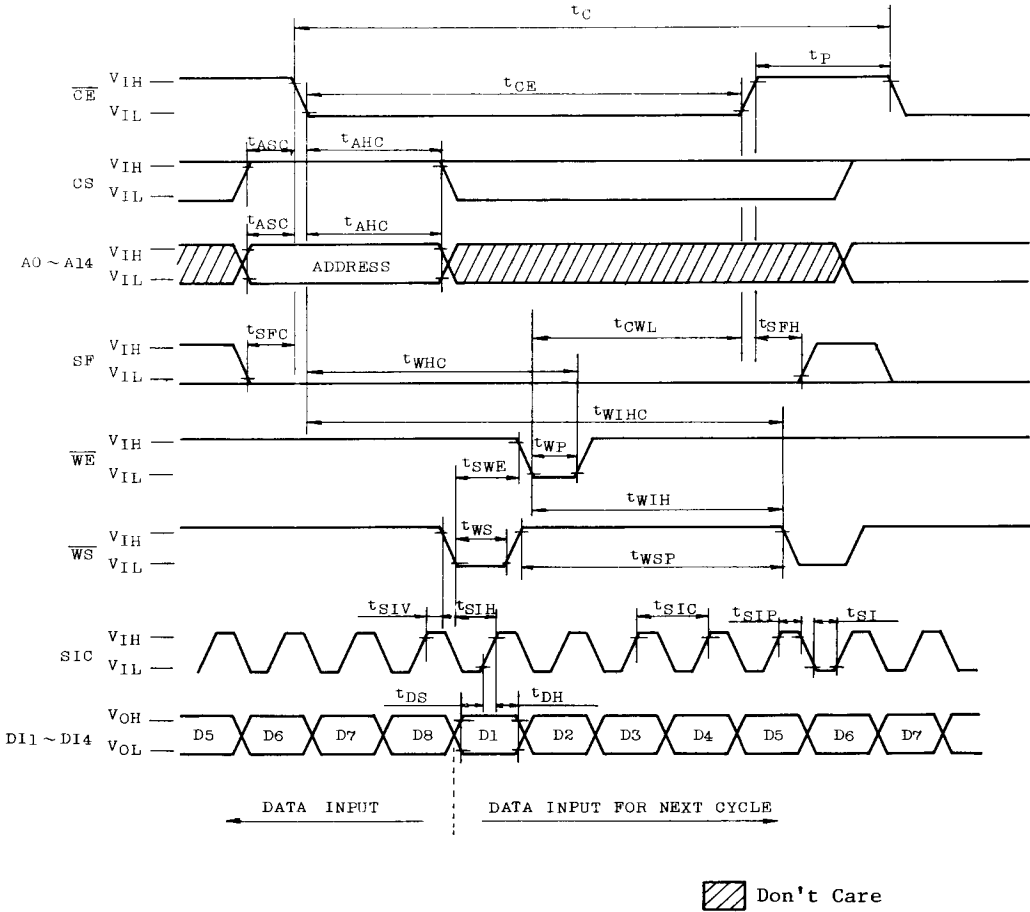
- (1) Stress greater than those listed under "Absolute maximum ratings" may cause permanent damage to the device.
- (2) All voltages are referenced to  $V_{SS}$ .
- (3)  $I_{CC1}$  and  $I_{CC2}$  depend on cycle time. These values are specified at the condition of minimum cycle time.
- (4)  $I_{CC1}$  depends on output loading. Specified value is obtained with the output open.
- (5) An initial pause of 200 $\mu$ s is required after power up followed by 8  $\overline{CE}$  cycles before proper device operation is achieved. In case of using auto refresh, a minimum of 8  $\overline{RFSH}$  cycle are required.
- (6) AC measurements assume  $t_T=5$ ns.
- (7)  $V_{IH}(\text{min.})$  and  $V_{IL}(\text{max.})$  are reference levels for measuring timing of input signals. Also transition times are measured between  $V_{IH}$  and  $V_{IL}$ .
- (8) Output timings are measured with a load equivalent to 2 TTL load and 30pF.  
DOUT compare level:  $V_{OH}/V_{OL}=2.0V/0.8V$
- (9)  $t_{OEZ}(\text{max.})$  defines the time at which the output achieve the open state.
- (10) Typical values are at  $T_a=25^\circ\text{C}$  and  $V_{CC}=5.0V$ .

READ/SERIAL READ CYCLE



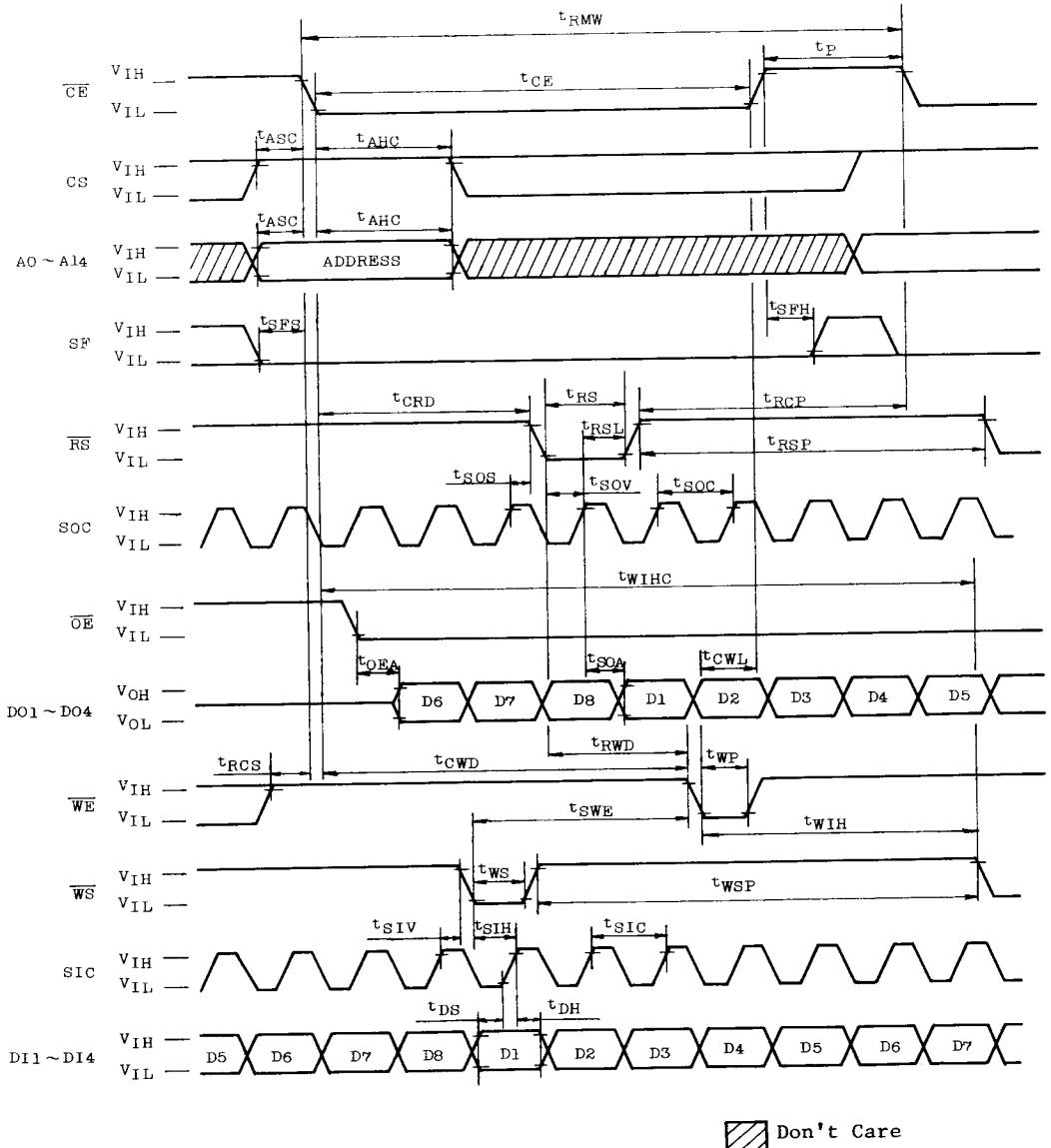
# TC521000P/J

## WRITE/SERIAL WRITE CYCLE



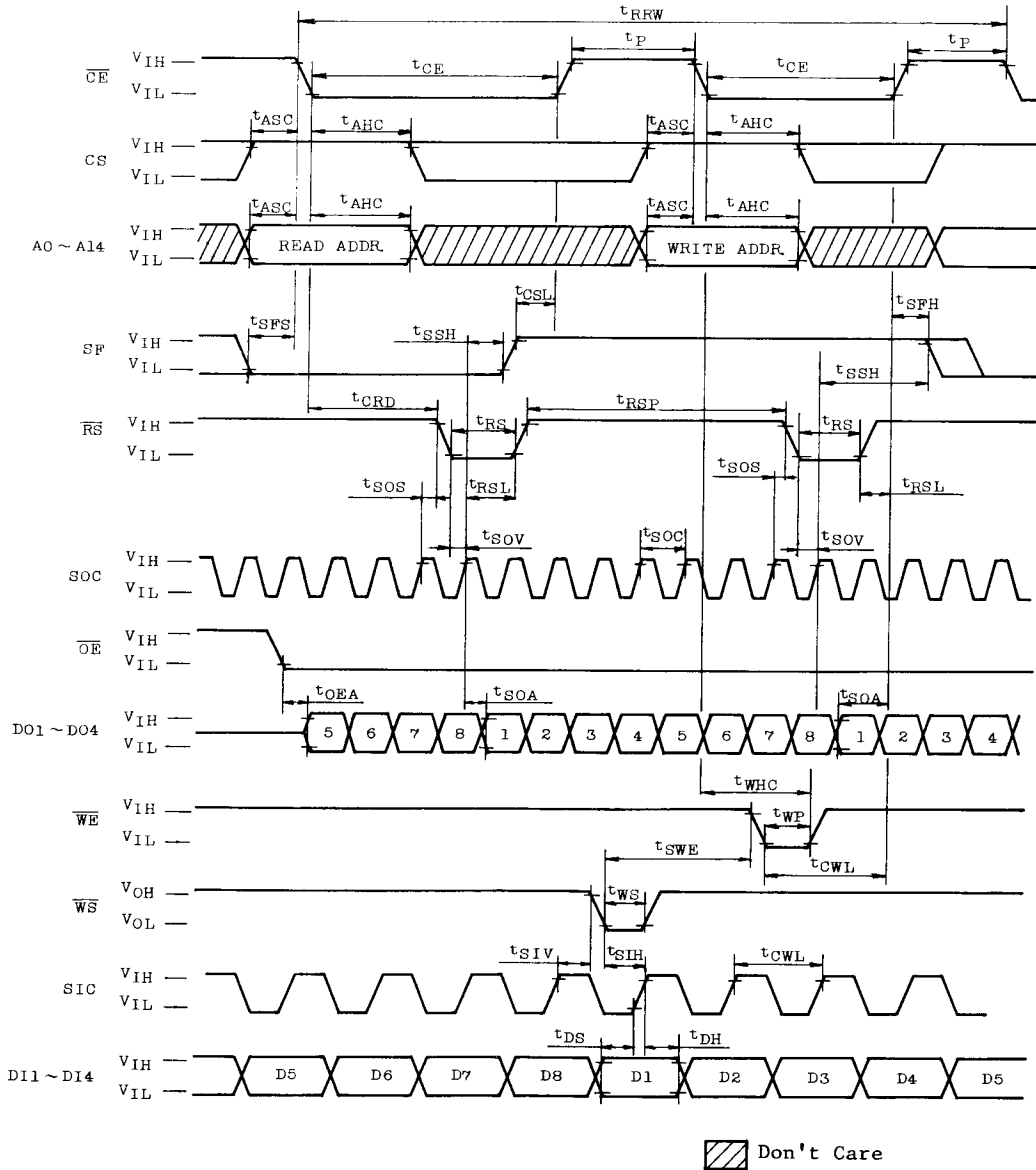


READ MODIFY WRITE CYCLE

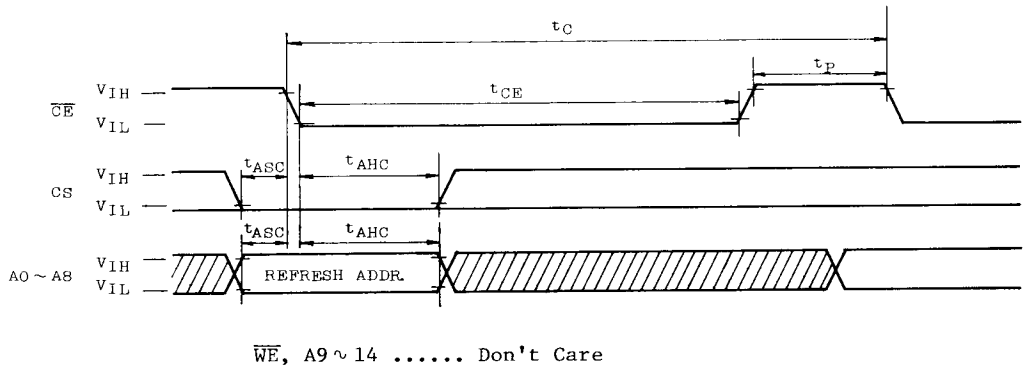


# TC521000P/J

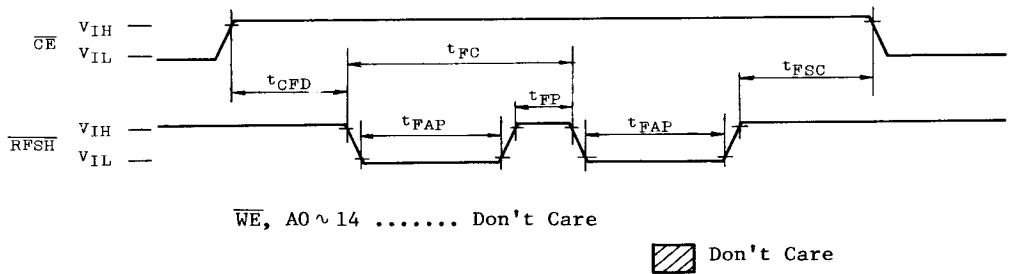
## READ-READ-WRITE CYCLE



**CE ONLY REFRESH**



**RFSH AUTO REFRESH**



# TC521000P/J

## OPERATION INFORMATION

### (1) READ/SERIAL READ CYCLE

#### i) SERIAL READ CYCLE (Refer to Fig. 1, 2)

- 1 The read address is latched at the falling edge of  $\overline{CE}$ . The 8 bit data read out are transferred to and latched into the read latch (RL).
- 2 The data latched at the RL are transferred to serial output register (SOR) at the first rising edge of SOC after the  $\overline{RS}$  goes low.
- 3 The 8 bit data transferred to the SOR are shifted and output sequentially synchronized with SOC from the first rising edge of SOC after the  $\overline{RS}$  falls.

Fig.1 Block Diagram

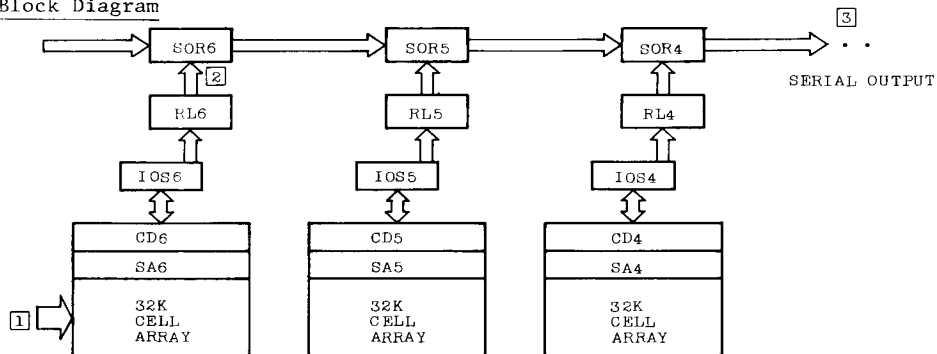
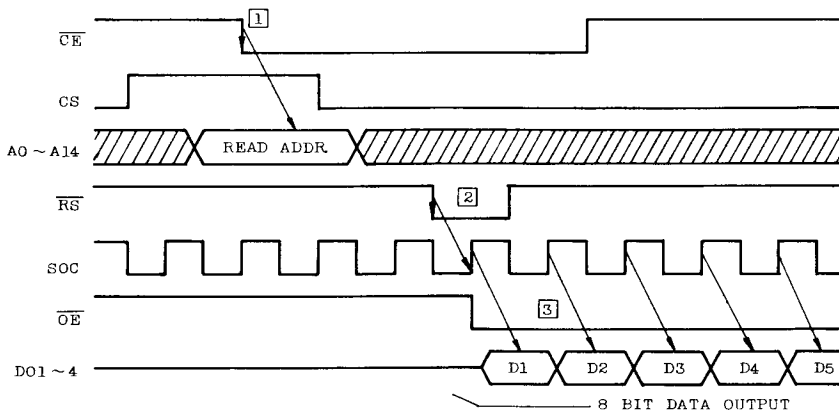


Fig.2 Timing Diagram



(2) WRITE/SERIAL WRITE CYCLE (Refer to Fig. 3, 4)

- 1 The 8 bit input data are latched into the 8 bit serial input register (SIR) sequentially synchronized with SIC.
- 2 The 8 bit input data latched into the SIR are transferred to the write latch (WL) at the falling edge of  $\overline{WS}$ .
- 3 The write address is latched at the falling edge of  $\overline{CE}$ , same as read operation. Then the data stored in selected address to be written are read out and latched into the RL independent of this write operation, so the read data latched there can be read out through SOR by using  $\overline{RS}$  and SOC (Read-Modify-Write).
- 4 The 8 bit input data latched into the WL are written into the selected address location at the falling edge of  $\overline{WE}$ .

Fig.3 Block Diagram

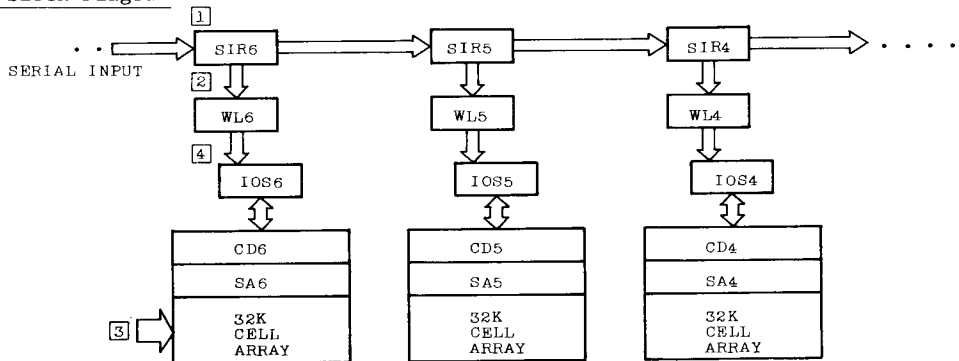
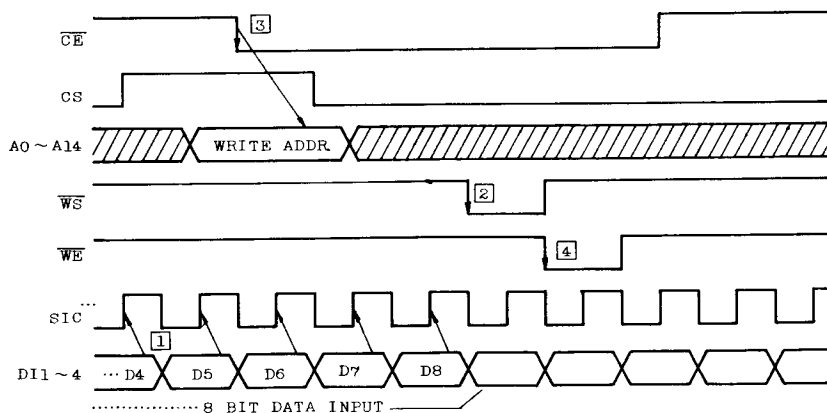


Fig.4 Timing Diagram



# TC521000P/J

## (3) READ-MODIFY-WRITE CYCLE

This operation is to execute write just after read in one  $\overline{CE}$  cycle.

## (4) READ-READ-WRITE CYCLE (Special operation) (Refer to Fig. 5, 6)

By using SF signal, three operations - the read operation for consecutive two address (16 bit data output) and write operation into the different address from read (8 bit data input) - can be performed asynchronously in two  $\overline{CE}$  cycles (480ns). In this operation, the read start address must be even. This operation capability allows the field double scan in order to improve the picture quality in TV applications.

- 1 The read address (even) is latched at the falling edge of  $\overline{CE}$  under the condition of SF=low. Then the 8 bit read out data are transferred to and latched into the RL.
- 2 The 8 bit data latched into the RL are transferred to SOR by the  $\overline{RS}$ , and then the data latched into the SOR are shifted and output from the first rising edge of SOC after the  $\overline{RS}$  falls.
- 3 Then when SF goes high, the LSB bit (A14) of column addresses is changed to "1" from "0" automatically, and the data in the next column address are transferred to and latched into the RL.
- 4 When the  $\overline{CE}$  goes high, only memory cell array its peripheral area except for the latch and serial registers are placed in a precharge state. Then the data latched into the RL and SOR are maintained there, so the  $\overline{WS}$  and  $\overline{RS}$  can be input.
- 5 On the other hand, the 8 bit input data are latched into the SIR sequentially synchronized with the SIC and then transferred to and latched into the WL by the  $\overline{WS}$ .
- 6 The write address is latched at the falling edge of  $\overline{CE}$ , and then the data stored in the selected address is read out, but the data already latched into the RL are protected and retained there because of maintaining the SF "high".
- 7 The 8 bit data latched into the RL (in 3) are transferred to and latched into the SOR by the  $\overline{RS}$ .
- 8 The 8 bit data latched into the WL (in 5) are written into the selected cell locations by the  $\overline{WE}$ .

Fig.5 Block Diagram

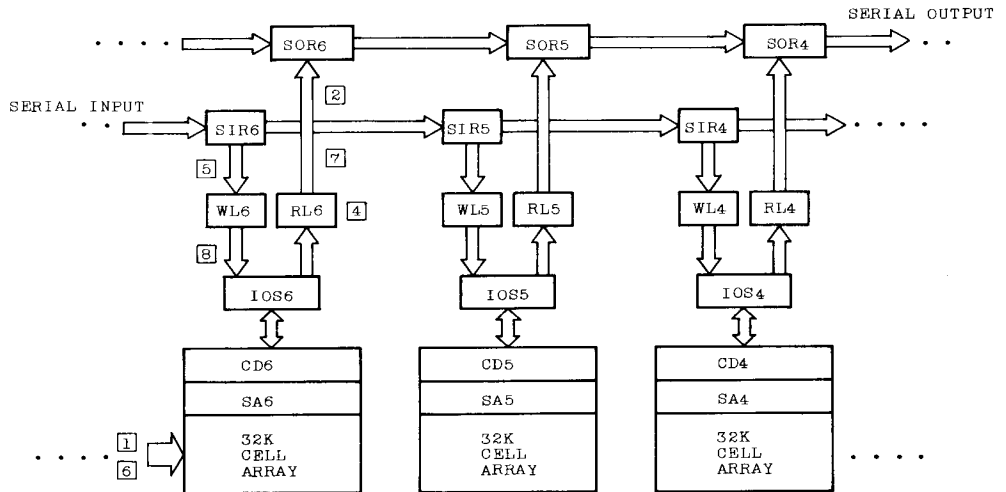
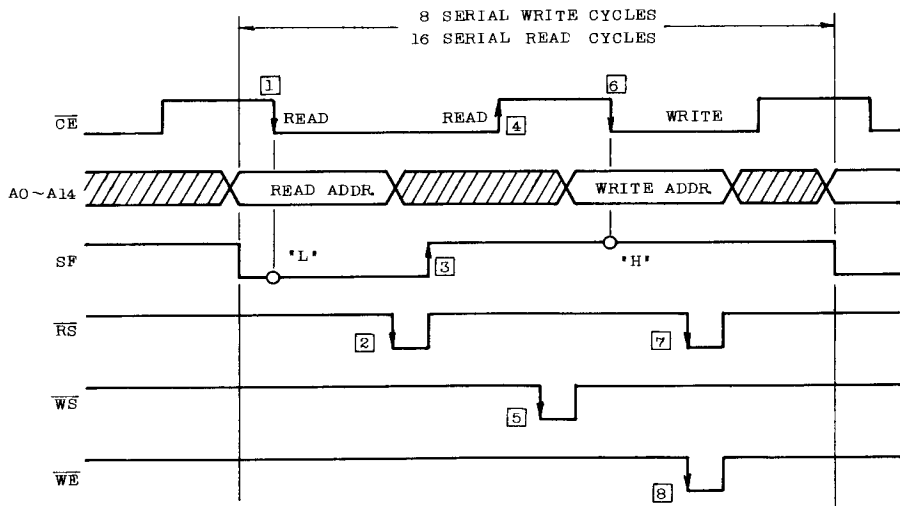


Fig.6 Timing Diagram



# TC521000P/J

## (5) REFRESH

The TC521000P/J's refresh period is 8ms/512 cycles.

The two types of refresh operation-- $\overline{CE}$  only refresh and  $\overline{RFSH}$  auto refresh--are allowed.

### 5-1: $\overline{CE}$ only refresh

The refresh is accomplished by performing a  $\overline{CE}$  cycle at each of the 512 row address (A0-A8) within each 8ms time interval.

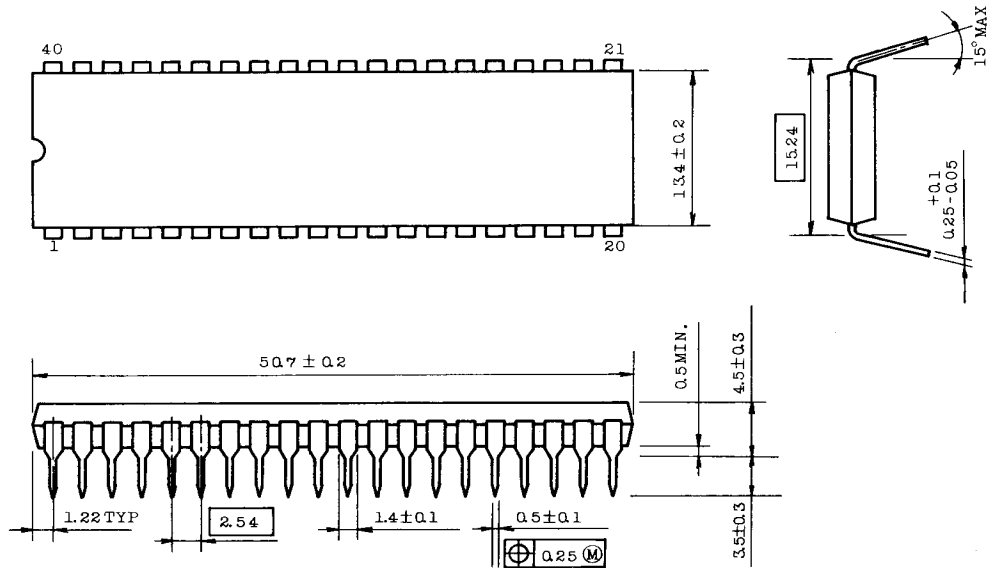
### 5-2: $\overline{RFSH}$ auto refresh

The  $\overline{RFSH}$  auto refresh is available on the TC521000P/J. When the  $\overline{RFSH}$  goes low under the condition of  $\overline{CE}$ =high, the on-chip refresh control clock generator and refresh address counters are enabled. Then, the refresh is accomplished by applying 512 clocks to the  $\overline{RFSH}$  input within an 8ms time interval.



OUTLINE DRAWINGS DIP40-P-600

Unit in mm



Note: Each lead pitch is 2.54mm. All leads are located within 0.25mm of their longitudinal position with respect to No.1 and No.40 leads.

# TC521000P/J

o 400 mil SOJ package:

